

Notice of References Cited	Application/Control No. 10/620,779		Applicant(s)/Patent Under Reexamination DENTER ET AL.	
	Examiner Hien D. Vu		Art Unit 2833	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,244,880	06-2001	Fukase et al.	439/157
	B	US-6,361,356	03-2002	Heberlein et al.	439/489
	C	US-6,254,407	07-2001	Burns, Mark V.	439/157
	D	US-2001/0019908	09-2001	Zweigle, Peter	439/157
	E	US-6,345,995	02-2002	Bigotto et al.	439/157
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
X	N	0945928 A2	09-1999	EP	Tsuji et al	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.